

Search Notes

Application/Control No.

10/767,644

Examiner

Mark T. Le

Applicant(s)/Patent under
Reexamination

KURZO, YVAN

Art Unit

3617

SEARCHED

Class	Subclass	Date	Examiner
187	408	6/07	~
238	283	I	I
	382		
	284		
	285		
	302		
	349		
	351	I	I

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR